# High Where power supply design meets collaboration

Designing reliable and high density power solutions with GaN

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#### What will I get out of this session?

- GaN is enabling new levels of power density and efficiency.
- Integration for System
  Performance and Reliability
- GaN Applications

- Relevant Part Numbers
  - LMG3410Rxxx/LMG3411Rxxx
  - LMG5200

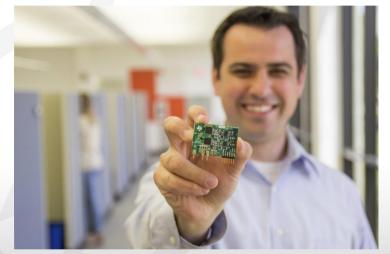


# Why GaN?



#### GaN: Ready to Take you Beyond Silicon Today

- GaN devices are enabling solutions with twice the power density of what is possible with best-in-class superjunction FETs
- TI GaN solutions, such as LMG5200 and LMG3410R070, are in mass production and in many customer systems
- These systems are not only smaller and more efficient, but are also in cost and system parity with their silicon predecessors.
- Lets find out how!



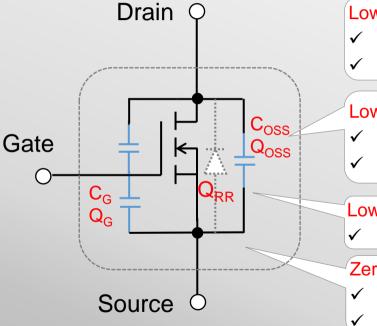


#### GaN: Unmatched Power Density from AC-to-Motor





#### GaN 101: Key Advantages Over Silicon



Low  $C_G, Q_G$  gate capacitance/charge (1 nC- $\Omega$  vs Si 4 nC- $\Omega$ )

- faster turn-on and turn-off, higher switching speed
- reduced gate drive losses

Low C<sub>OSS</sub>,Q<sub>OSS</sub> output capacitance/charge (5 nC-Ω vs Si 25 nC-Ω) ✓ faster switching, high switching frequencies

reduced switching losses

Low  $R_{DSON}$  (5 m $\Omega$ -cm<sup>2</sup> vs Si >10 m $\Omega$ -cm<sup>2</sup>)

- Iower conduction losses
- Zero Q<sub>RR</sub> No 'body diode'
- No reverse recovery losses
- Reduces ringing on switch node and EMI





## Driver and Protection Integration for Higher System Performance

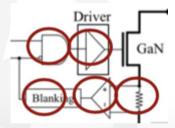


#### Not All GaN is Created Equal

#### **TI GaN: Fully Integrated**

# RDRV

#### **Discrete GaN**

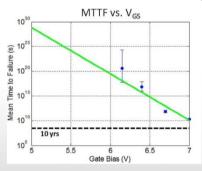


Driver	Integrated	External
EMI Control	Integrated	External
100ns OCP	Integrated	External
Added PCB Area	0	>400mm <sup>2</sup>

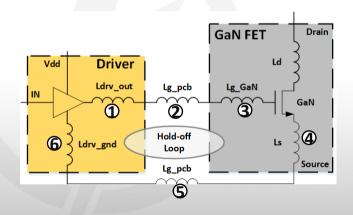


Challenges of GaN Designs with External Driver and Protection

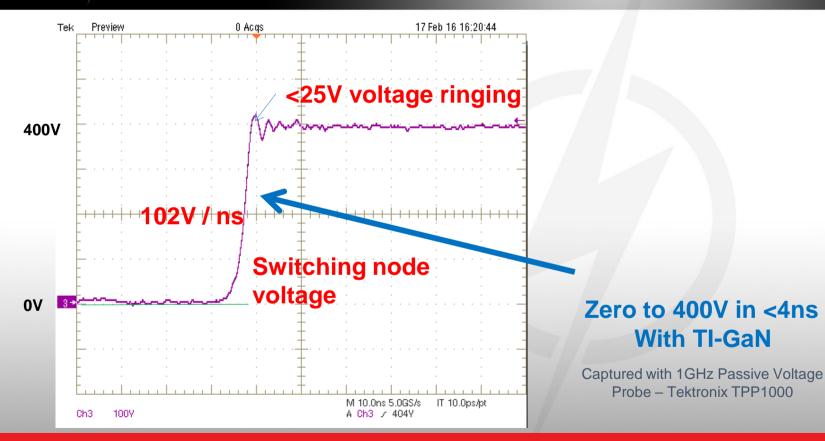
 Driver Bias Voltage: GaN gate bias is critical to its performance and longterm device reliability



 Protection: Designing a robust overcurrent protection circuit at MHz frequency and high slew rate is difficult and costly.  Parasitic Inductance: causes switching loss, ringing and reliability issues, especially at high GaN frequencies









#### Overcurrent and Shoot-through Protection

OCP Performance	System Impact	Cost
Poor SNR	<ul><li> High power loop inductance</li><li> Power losses</li></ul>	<ul><li>Sense resistor</li><li>High speed comparator ()</li></ul>
<100ns Response	None	No external components
	• Poor SNR	Poor SNR  High power loop inductance  Power losses

- High value sense resistor is needed for SNR
- Increases power loop which slows down the dv/dt for the given overshoot (100V/ns drops to 80V/ns)
- Increased power losses due lower dv/dt and sense resistor

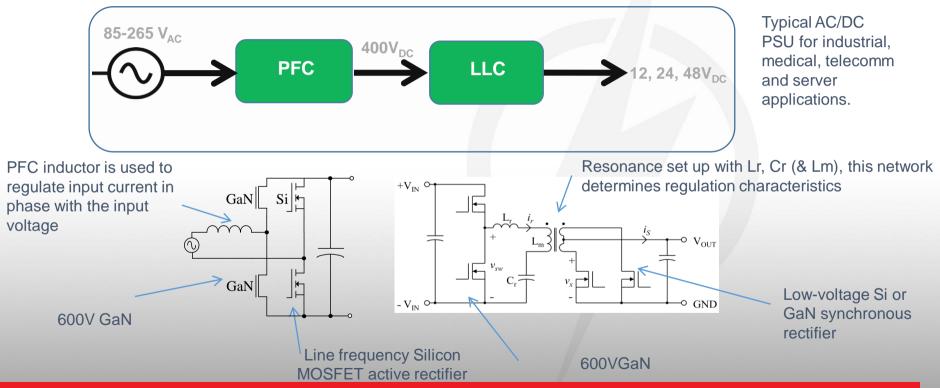
Parameter	Resistive Shunt 2X 12mΩ (25mΩ /2)
Added PCB Area	233 mm <sup>2</sup>
Added Power Loop Inductance	1.2nH
dv/dt	80V/ns
Additional Power Loss at 100kHz Po=1.2kW	0.9W



## GaN Application Examples



#### AC/DC: Applications and Topology

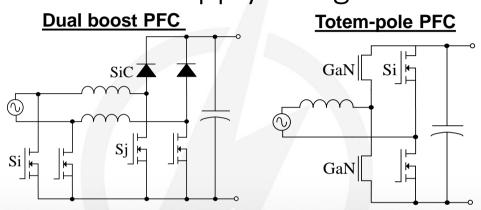






#### GaN CCM Solution: Superior Power Supply Design

- Higher efficiency
  - Reduced power loss by 36%
- Higher power density
  - 3X power density in Totem-pole PFC versus Silicon
- Solution cost parity
  - Reduced magnetics and external components bring total solution cost down



Loss Mechanism	Dual Boost PFC with Silicon	Totem-pole PFC with GaN
Switching FET Cond.	0.6 W	2.06 W
SiC Diode Cond.	2.75W	-
FET Eoss / SiC Diode Qoss	3.9 W	2.4W
I-V Overlap	1.47 W	0.95W
Rect. Diodes / FETs	0.45 W (FET)	0.45 W (FET)
Total Power Losses	9.17W	<b>5.86W</b>



#### GaN CrM Solution: 1.6kW Totem-Pole PFC

Parameter	Value
Input Voltage	85 – 265 V <sub>AC</sub>
Input Frequency	50 – 60 Hz
Output Voltage	385 V <sub>DC</sub>
Output Power	1 kW
Switching Frequency	100 kHz / 140 kHz

Power Density: 250 W/in<sup>3</sup> (9.5 W/cm<sup>3</sup>) GaN FETs (LMG3410-HB-EVM)

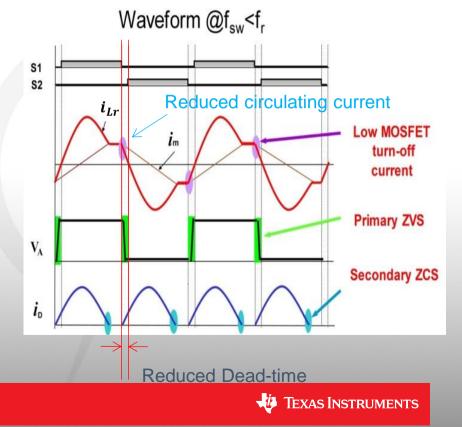




#### GaN in LCC: Superior Power Supply Design

#### • Reduced Output Capacitance Coss

- reduces dead-time, increasing the time when current delivered to the output
- allows larger magnetizing inductance and lower circulating current losses as well as transformer fringe-field losses
- Reduced Gate Driver Losses
- System Optimization
  - GaN enables higher switching frequency to reduce magnetic components significantly
  - GaN enables LLC converter with higher efficiency and higher power density



#### TI-GaN: 1MHz Isolated LLC DCDC Converter

Parameter	Value
Input Voltage	380 – 400V
Switching Frequency	≤ 1MHz
Output Voltage	48V
Output Power	1 kW
Switching Frequency	≤ 1MHz
Efficiency	>97%

Power Density: 140 W/in3 (8.5 W/cm3)

#### GaN FETs (LMG3410-HB-EVM)

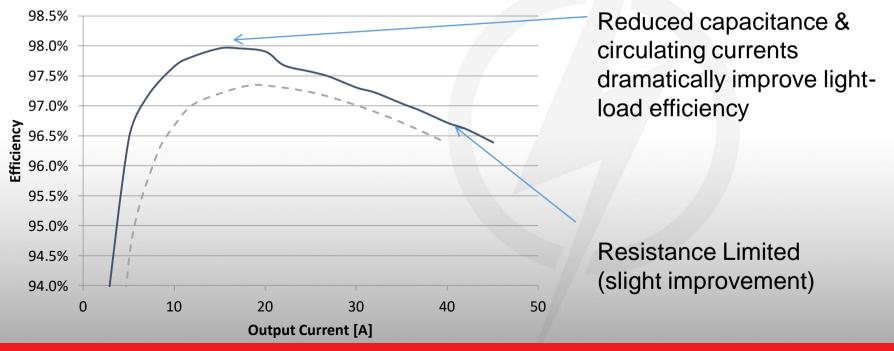




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#### Efficiency: Comparison with MOSFET

-GaN - - - Si Superjunction





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#### GaN: Enabling Smart Motor Drive

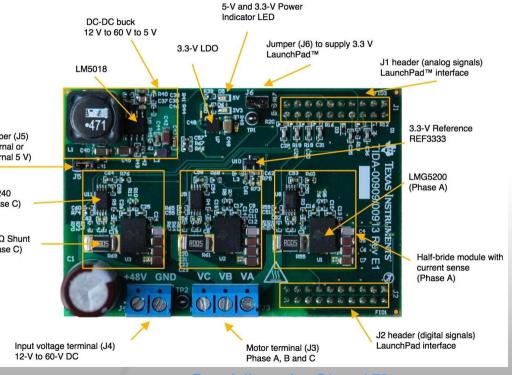
- GaN reduces or eliminates heatsink
- GaN reduces or eliminates switch node oscillations
  - Lower radiated EMI, no additional snubber network (space, losses) required
- GaN increases PWM frequency and reduces switching losses
  - Drive very low inductance PM synchronous motors or BLDC motors
  - Precise positioning in servo drives/steppers through minimum torque ripple
  - High-speed motors (e.g. drone) achieves sinusoidal voltage above 1-2kHz frequency
- GaN eliminates dead-time distortions of phase voltage
  - Better light load and THD performance





#### 48V 10A 3Φ Inverter for High-Speed Motors

Parameter	Value	
Input Voltage	12 – 60 V <sub>DC</sub>	
Input Power	400W	
Output Voltage	48 V <sub>DC</sub>	Jumper (J5) (internal or external 5 V)
Output Current	10-A <sub>Peak</sub>	INA240
Switching Frequency	100 kHz	(Phase C) 5-mΩ Shunt (Phase C)
Peak Efficiency	98.5%	
Power Density: 5 W/cm <sup>3</sup>		Input volta 12-V to 60

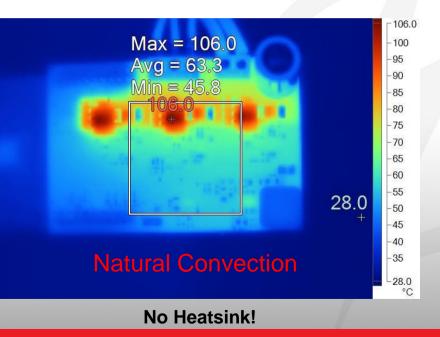


Board dimension 54mm \* 79mm



#### 48V GaN Inverter: Thermal Performance

#### 48V/10A with 98.5% Efficiency







# Wrap-Up



#### Conclusion

- GaN is enabling a new generation of power conversion designs today, that were not possible before
- GaN enables 3X power density improvement from AC to Point-of-Load
- 1MHz isolated LLC design delivers 6x reduction in size and weight of the solution
- Integration of driver and GaN in a low inductance package provides an optimal solution for fast and reliable switching
- For products, designs, and training material, visit <u>Ti.com/GaN</u>





IEXAS INSTRUMENTS

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